

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
		Examiner Houshang Safaipour	Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,353,485	03-2002	Kaneko, Kiyoshi	358/1.2
*	B	US-6,600,578	07-2003	Huang, Yin-Chun	358/474
*	C	US-6,519,047	02-2003	Ahn, Byung-Sun	358/1.12
*	D	US-6,276,771	08-2001	Kim et al.	347/3
*	E	US-5,267,056	11-1993	Stemmle, Denis J.	358/472
*	F	US-5,162,916	11-1992	Stemmle et al.	358/296
*	G	US-4,827,355	05-1989	Kotani et al.	358/296
*	H	US-6,688,739	02-2004	Murray, Richard A.	347/104
*	I	US-5,376,987	12-1994	Onuki, Kazuhiko	355/45
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.